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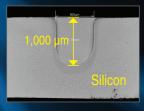
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- 500 poster presentations over 4 days
- >120

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 - 35
- named symposia in Physical, Biological, and Analytical Sciences

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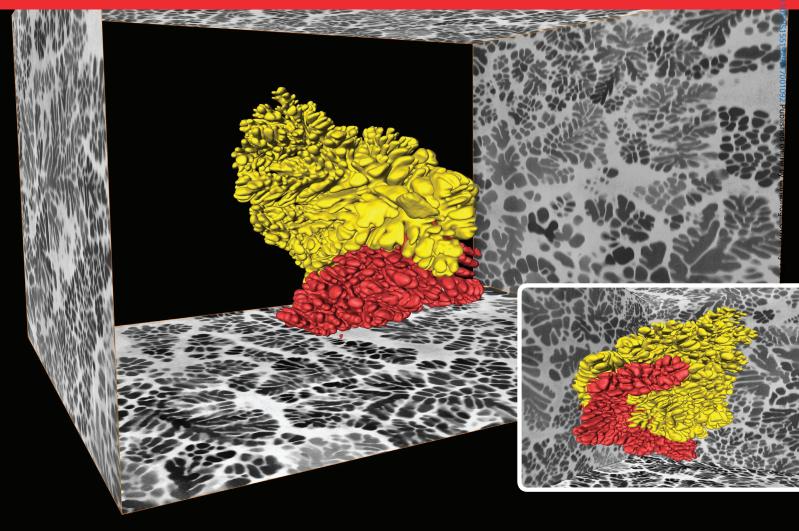
- 7 traditional day-long Sunday Short Courses
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Thermo ScientificTM AvizoTM 3D visualization of two large adjacent crystalline dendrites of a bulk-metallic-glass matrix composite $(Zr_{ss,s}^{-}Ti_{i,3}Nb_{s,2}Cu_{s,1}Ni_{4,9}Be_{11,0})$. Data was obtained by large volume serial sectioning tomography using the Thermo Scientific HeliosTM PFIB DualBeamTM microscope. The sectioned block is about 90×80×70 µm³. Sample from The University of Tennessee, USA. Images courtesy of The University of Manchester.

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Until recently, available technologies have limited the volumes and depths of materials that can be analyzed at high resolution, ultimately restricting the insight into structural, crystallographic, and chemical properties. This is no longer the case. The Thermo Scientific Helios PFIB DualBeam microscope offers unrivaled access to regions of interest deep below the surface—combining serial section tomography with statistically relevant data analysis.

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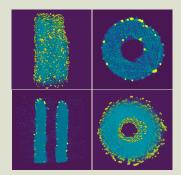
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3D visualizations and 2D crosssectional slices of Pt nanoparticles (yellow) on a hollow carbon nanofiber using *tomviz* software. Clockwise from upper left: 3D outside longitudinal view, 2D cross section, 3D axial view, and 2D longitudinal section. Full width left images = 420 nm. Full width right images = 220 nm.

See article by Levin et al.

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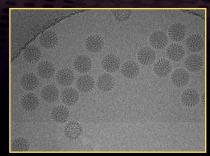


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Frozen-hydrated Bacteriophage Capsid (data acquired on CF-1.2/1.4-4C).

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Consistent

Researchers around the world have reported that the ultra-flat surface of C-flat[™] leads to even ice thickness and uniform particle distribution, allowing for superior 3-D reconstructions. 2 µm hole sizes are standard, but various hole sizes are available to accommodate different particle sizes and magnifications.

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